



AI – TREATS

2nd Workshop on AI Hardware: Test, Reliability, and Security

Barcelona, Spain

(Hybrid Format)

May 26-27, 2022

<https://ai-treats-workshop.aalto.fi/>

Call for Contributions

Recent advances in Artificial Intelligence (AI), in particular deep learning, have led to numerous applications, including computer vision, speech recognition, natural language processing, robotics, etc. Autonomous vehicles are also afoot and AI will be the core enabling technology. In parallel, there is intense activity in designing dedicated hardware for AI. On one hand, AI hardware accelerators are demanded to support the tremendous processing power, unprecedented speed, and memory costs that deep neural networks require so as to realize their full potential. On the other hand, there is a large incentive for moving the AI algorithms execution from the cloud into the edge devices, i.e. Internet-of-Things (IoT) devices, in particular for meeting data confidentiality and network bandwidth requirements and eliminating the communication latency. Edge devices are expected to include local AI processing, yet this is challenging as an edge device is a resource-constrained environment. AI hardware design efforts rapidly evolve exploring various architectures (e.g., machine learning-based, spiking), design flavors (e.g., digital, mixed analog-digital), and emerging technologies (e.g., memristive devices arranged into crossbars to implement efficiently the multiply-add matrix operations in neural networks). The aim of this Workshop is to focus particularly on the following emerging problems pertaining to AI hardware:

- **Testing:** fault modelling, fault simulation, test generation, post-manufacturing testing, design-for-test, built-in self-test, on-line testing, fault diagnosis.
- **Reliability:** reliability analysis, design-for-reliability, fault-tolerance, self-repair, functional safety.
- **Hardware security and trust:** IP/IC piracy, hardware Trojans, side-channel attacks, fault injection attacks.

Perspective speakers are invited to submit an abstract, an extended abstract of up to 2 pages or a complete 6-page paper using the submission system: <https://easychair.org/conferences/?conf=aitreats22>. An informal digest of abstracts and papers will be distributed to the attendees. We seek talks on novel scientific works or preliminary results, as well as perspective talks.

The Workshop will take place in conjunction with the 27th IEEE European Test Symposium.

Key dates:

Submission of abstracts and papers: **April 15th, 2022**

Notification of acceptance: **April 20th, 2022**



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